## Notice of References Cited Application/Control No. 10/735,482 Examiner Trenton J. Roche Applicant(s)/Patent Under Reexamination NEUMANN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,475,843 A	12-1995	Halviatti et al.	717/124
*	В	US-6,031,531 A	02-2000	Kimble, Christopher John	715/862
*	С	US-2002/0085037 A1	07-2002	Leavitt et al.	345/765
*	D	US-6,583,781 B1	06-2003	Joshi et al.	345/156
*	Ε	US-2004/0015862 A1	01-2004	Dunn, Jeffrey J.	717/124
*	F	US-6,889,337 B1	05-2005	Yee, David	714/1
	G	US-			
	Η	US-			
	_	US-			
	7	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Р					
	Q		•	·		
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ	J. Chen et al., "Specification-based Testing for GUI-based Applications", 2002					
	٧						
:	w						
	×						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.